





## **MPE TEST REPORT**

**Applicant** Cypress Semiconductor

FCC ID WAP3063

**Product** EZ-BT WICED Module

CYBT-273063-02

Model CYBT-263064-02

CYBT-263065-02

**Report No.** R1911A0639-M1

**Issue Date** January 3, 2020

TA Technology (Shanghai) Co., Ltd. tested the above equipment in accordance with the requirements in **FCC 47 CFR Part 1 1.1310**. The test results show that the equipment tested is capable of demonstrating compliance with the requirements as documented in this report.

Performed by: Yu Wang

Approved by: Guangchang Fan

Guangchang Fan

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**Test Laboratory** 

**Notes of the Test Report** 

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(shanghai) co., Ltd. The results documented in this report apply only to the tested sample, under the

conditions and modes of operation as described herein . Measurement Uncertainties were not taken

into account and are published for informational purposes only. This report is written to support

regulatory compliance of the applicable standards stated above.

**Test facility** 1.2

FCC (Designation number: CN1179, Test Firm Registration Number: 446626)

TA Technology (Shanghai) Co., Ltd. has been listed on the US Federal Communications Commission

list of test facilities recognized to perform electromagnetic emissions measurements.

A2LA (Certificate Number: 3857.01)

TA Technology (Shanghai) Co., Ltd. has been listed by American Association for Laboratory

Accreditation to perform electromagnetic emission measurement.

**Testing Location** 

Company:

TA Technology (Shanghai) Co., Ltd.

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### 1.4 Laboratory Environment

Temperature	Min. = 18°C, Max. = 25 °C		
Relative humidity	Min. = 30%, Max. = 70%		
Ground system resistance	< 0.5 Ω		
Ambient noise is checked and found very lo	w and in compliance with requirement of standards.		

Ambient noise is checked and found very low and in compliance with requirement of standards. Reflection of surrounding objects is minimized and in compliance with requirement of standards.



2 Description of Equipment under Test

#### **Client Information**

Applicant Cypress Semiconductor		
Applicant address	198 Champion Ct, San Jose, California 95134, United States	
Manufacturer	Cypress Semiconductor	
Manufacturer address	198 Champion Ct, San Jose, California 95134,United States	

#### **General Technologies**

	CYBT-273063-02		
Model	CYBT-263064-02		
	CYBT-263065-02		
SN	1#		
Hardware Version	REV1.0		
Software Version	REV1.0		
Date of Testing:	December 6, 2019 ~ December 20, 2019		

Note: 1. The EUT is sent from the applicant to TA and the information of the EUT is declared by the applicant.

2. All indications of Pass/Fail in this report are opinions expressed by TA Technology (Shanghai) Co., Ltd. based on interpretations and/or observations of test results. Measurement Uncertainties were not taken into account and are published for informational purposes only.

Difference Configuration Statement					
Model	CYBT-273063-02	CYBT-263064-02	CYBT-263065-02		
The configuration of antenna	PCB antenna	External antenna via RF pin on the bottom of the module	External dipole antenna via UFL connector		
Antenna gain	0.7dBi	2.0dBi	2.0dBi		
Others	The same	The same	The same		

The difference between the two EUT is only the configuration of antenna and antenna gain. There are more than one Configure, each one should be applied throughout the compliance test respectively, however, the worst case (CYBT-263065-02) will be recorded for conducted items and the radiated items are recorded for all.

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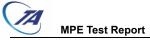


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### 3 Maximum conducted output power (measured) and antenna Gain

The numeric gain (G) of the antenna with a gain specified in dB is determined by Numeric gain (G)=10^(antenna gain/10)

Band	Maximum Conducted Output Power (dBm)		Antenna Gain	Numeric gain
	(dBm)	(mW)	(dBi)	
BLE	15.800	38.019	2.000	1.585
ВТ	15.480	35.318	2.000	1.585



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#### 4 Test Result

According to section 1.1310 of FCC 47 CFR Part 1, limits for maximum permissible exposure (MPE) are as following

TABLE 1 - LIMITS FOR MAXIMUN PERMISSIBLE EXPOSURE (MPE)

Frequency Range	Electric Field	Magnetic Field	Power Density	Averaging Time
(MHz)	Strength	Strength		250
A-1-0-17	(V/m)	(AVm)	(mW/cm2)	(minutes)
	(A) Limits for Occu	upational/Controlle	d Exposures	
0.3-3.0	614	1.63	*(100)	6
3-30	1842/f	4.89/f	*(900/f2)	6
30-300	61.4	0.163	1.0	6
300-1500			f/300	6
1500-100,000			5	6
(B)	Limits for General	Population/Uncont	rolled Exposure	
0.3-1.34	614	1.63	*(100)	30
1.34-30	824/f	2.19/f	*(180/f2)	30
30-300	27.5	0.073	0.2	30
300-1500			f/1500	30
1500-100,000			1.0	30

f = frequency in MHz

Note1. Occupational/controlled limits apply in situations in which persons are exposed as a consequence of their employment provided those persons are fully aware of the potential for exposure and can exercise control over their exposure. Limits for occupational/controlled exposure also apply in situations when an individual is transient through a location where occupational / controlled limits apply provided he or she is made aware of the potential for exposure.

Note2: General population/uncontrolled exposures apply in situations in which the general public may be exposed, or in which persons that are exposed as a consequence of their employment may not be fully aware of the potential for exposure or can not exercise control over their exposure.

<sup>\* =</sup> Plane-wave equivalent power density



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The maximum permissible exposure for 1500~100,000MHz is 1.0.So

Band	The maximum permissible exposure	
BLE	1.0mW/cm <sup>2</sup>	
ВТ	1.0mW/cm <sup>2</sup>	



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#### **RF Exposure Calculations:**

distance is less.

The following information provides the minimum separation distance for the highest gain antenna provided. This calculation is based on the conducted power, considering maximum power and antenna gain. The formula shown in KDB 447498 D01 is used in the calculation.

Equation from KDB 447498 D01 General RF Exposure Guidance v06 (10/23/2015) is:

$$S = PG / 4 \square R^2$$

Where: S = power density (in appropriate units, e.g. mW/cm<sup>2</sup>)

P = Time-average maximum tune up procedure (in appropriate units, e.g., mW)

G = the numeric gain of the antenna

R = distance to the center of radiation of the antenna (20 cm = limit for MPE)

Band	PG (mW)	Test Result (mW/cm <sup>2</sup> )	Limit Value (mW/cm <sup>2</sup> )	Conclusion
BLE	60.256	0.012	1.000	Pass
ВТ	55.976	0.011	1.000	Pass
Note: <b>R</b> = 20cm				
∏= 3.1416				

Note: For transmitters, minimum separation distance is 20cm, even if calculations indicate MPE

\*\*\*\*\*\*END OF REPORT \*\*\*\*\*\*